

## **DS26F32M Quad Differential Line Receivers**

## **General Description**

The DS26F32 is a guad differential line receiver designed to meet the requirements of EIA Standards RS-422 and RS-423, and Federal Standards 1020 and 1030 for balanced and unbalanced digital data transmission.

The DS26F32 offers improved performance due to the use of state-of-the-art L-FAST bipolar technology. The L-FAST technology allows for higher speeds and lower currents by utilizing extremely short gate delay times. Thus, the DS26F32 features lower power, extended temperature range, and improved specifications.

The device features an input sensitivity of 200 mV over the input common mode range of ±7.0V. The DS26F32 provides an enable function common to all four receivers and TRI-STATE ® outputs with 8.0 mA sink capability. Also, a fail-safe input/output relationship keeps the outputs high when the inputs are open.

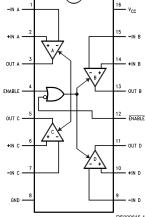
The DS26F32 offers optimum performance when used with the DS26F31 Quad Differential Line Driver.

#### **Features**

- Military temperature range
- Input voltage range of ±7.0V (differential or common mode) ±0.2V sensitivity over the input voltage range
- Meets all the requirements of EIA standards RS-422 and RS-423
- High input impedance (18k typical)
- 30 mV input hysteresis
- Operation from single +5.0V supply
- Input pull-down resistor prevents output oscillation on unused channels
- TRI-STATE outputs, with choice of complementary enables, for receiving directly onto a data bus
- Propagation delay 15 ns typical

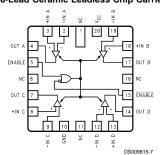
## **Connection Diagrams**

# 16-Lead DIP



**Top View** See NS Package Number J16A For Complete Military Product Specifications, refer to the appropriate SMD or MDS. Order Number DS26F32ME/883. DS26F32MJ/883 or DS26F32MW/883 See NS Package Number E20A, J16A or W16A

## 20-Lead Ceramic Leadless Chip Carrier



#### **Function Table**

(Each Receiver)

Differential Inputs	Enables		Outputs	
$V_{ID} = (V_{IN} +) - (V_{IN} -)$	Е	Ē	OUT	
$V_{ID} \ge 0.2V$	Н	Χ	Н	
	X	L	Н	
$V_{ID} \leq -0.2V$	Н	Χ	L	
	X	L	L	
X	L	Н	Z	

H = High Level

L = Low Level

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## **Absolute Maximum Ratings** (Note 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Storage Temperature Range

 $-65^{\circ}\text{C}$  + to  $175^{\circ}\text{C}$ Ceramic DIP

Operating Temperature Range

DS26F32M  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ DS26F32C 0°C to +70°C

Lead Temperature

Ceramic DIP (soldering, 60

sec)

Maximum Power Dissipation (Note 1) at 25°C

300°C

Cavity Package 1500 mW Supply Voltage 7.0V Common Mode Voltage Range ±25V Differential Input Voltage ±25V Enable Voltage 7.0V Output Sink Current 50 mA

## **Operating Range**

DS26F32M

Temperature -55°C to +125°C 4.5V to 5.5V Supply Voltage

Note 1: Derate cavity package 10 mW/°C above 25°C.

#### **Electrical Characteristics** (Notes 3, 4)

Over operating range, unless otherwise specified

Symbol	Parameter	Conditions		Min	Тур	Max	Units
V <sub>TH</sub>	Differential Input Voltage $-7.0V \le V_{CM} \le +7.0V$ ,		OV,	-0.2	±0.06	+0.2	V
		V <sub>O</sub> = V <sub>OL</sub> or V <sub>OH</sub>					
R <sub>I</sub> Input Resistance		-15V ≤ V <sub>CM</sub> ≤ +15	$-15V \le V_{CM} \le +15V$ ,		18		kΩ
		One Input AC Grou	One Input AC Ground				
I <sub>I</sub>	Input Current (under Test)	V <sub>I</sub> = +15V,	V <sub>I</sub> = +15V,			2.3	
		Other Input -15V ≤	Other Input −15V ≤ V <sub>I</sub> ≤ +15V				mA
		V <sub>I</sub> = -15V,	V <sub>1</sub> = -15V,			-2.8	
		Other Input -15V ≤					
V <sub>OH</sub> C	Output Voltage HIGH	V <sub>CC</sub> = Min,	0°C to +70°C	2.8	3.4		
		$\Delta V_1 = +1.0V,$					V
		$V_{\overline{\text{ENABLE}}} = 0.8V,$	-55°C to +125°C	2.5	3.4		
		$I_{OH} = -440  \mu A$					
V <sub>OL</sub>	Output Voltage LOW	V <sub>CC</sub> = Min,	I <sub>OL</sub> = 4.0 mA			0.4	
		$\Delta V_{I} = -1.0V,$	I <sub>OL</sub> = 8.0 mA			0.45	V
		$V_{\overline{\text{ENABLE}}} = 0.8V$					
V <sub>IL</sub>	Enable Voltage LOW					0.8	V
V <sub>IH</sub>	Enable Voltage HIGH			2.0			V
V <sub>IC</sub>	Enable Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = -18 mA				-1.5	V
l <sub>OZ</sub>	Off State (High Impedance)	V <sub>CC</sub> = Max	V <sub>O</sub> = 2.4V			20	μΑ
	Output Current		V <sub>O</sub> = 0.4V			-20	
I <sub>IL</sub>	Enable Current LOW	V <sub>1</sub> = 0.4V			-0.2	-0.36	mA
I <sub>IH</sub>	Enable Current HIGH	V <sub>I</sub> = 2.7V			0.5	10	μA
I <sub>I</sub>	Enable Input High Current	V <sub>I</sub> = 5.5V			1.0	50	μΑ
I <sub>os</sub> C	Output Short Circuit Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max, (Note 5)		-15	-50	-85	mA
		$\Delta V_{I} = +1.0V$					
I <sub>CC</sub> Su	Supply Current	V <sub>CC</sub> = Max, All V <sub>I</sub> = GND,			30	50	mA
	Outputs Disabled						
$V_{HYST}$	Input Hysteresis	T <sub>A</sub> = 25°C, V <sub>CC</sub> =		30		mV	

Note 2: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 3: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS26F32M and across the 0°C to +70°C range for the DS26F32C. All typicals are given for V  $_{CC}$  = 5V and T  $_{A}$  = 25  $^{\circ}$ C.

Note 4: All currents into the device pins are positive; all currents out of the device pins are negative. All voltages are reference to ground unless otherwise specified. Note 5: Only one output at a time should be shorted.

## Switching Characteristics $V_{CC}$ = 5.0V, $T_A$ = 25°C

Symbol	Parameter	Conditions		Min	Тур	Max	Units
t <sub>PLH</sub>	Input to Output	(Figures 2, 3)	C <sub>L</sub> = 15 pF		15	22	ns
t <sub>PHL</sub>	Input to Output				15	22	ns
t <sub>LZ</sub>	Enable to Output		C <sub>L</sub> = 5 pF		14	18	ns
t <sub>HZ</sub>	Enable to Output	(Figures 2, 4)			15	20	ns
t <sub>ZL</sub>	Enable to Output		C <sub>L</sub> = 15 pF		13	18	ns
t <sub>ZH</sub>	Enable to Output				12	16	ns

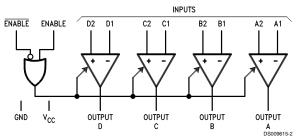


FIGURE 1. Logic Symbol

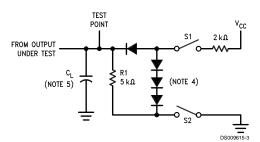


FIGURE 2. Load Test Circuit for Three-State Outputs

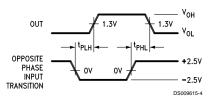
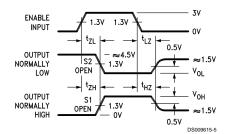


FIGURE 3. Propagation Delay (Notes 6, 7, 8)

## **Switching Characteristics** (Continued)



Note 6: Diagram shown for  $\overline{\text{ENABLE}}$  Low.

Note 7: S1 and S2 of Load Circuit are closed except where shown.

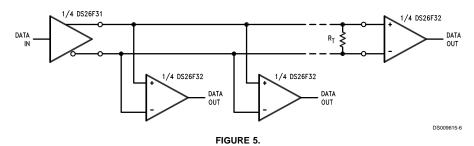
 $\textbf{Note 8:} \quad \text{Pulse Generator of all Pulses: Rate} \leq 1.0 \text{ MHz, Z}_{O} = 50\Omega, \ t_f \leq 6.0 \text{ ns, } t_f \leq 6.0 \text{ ns.}$ 

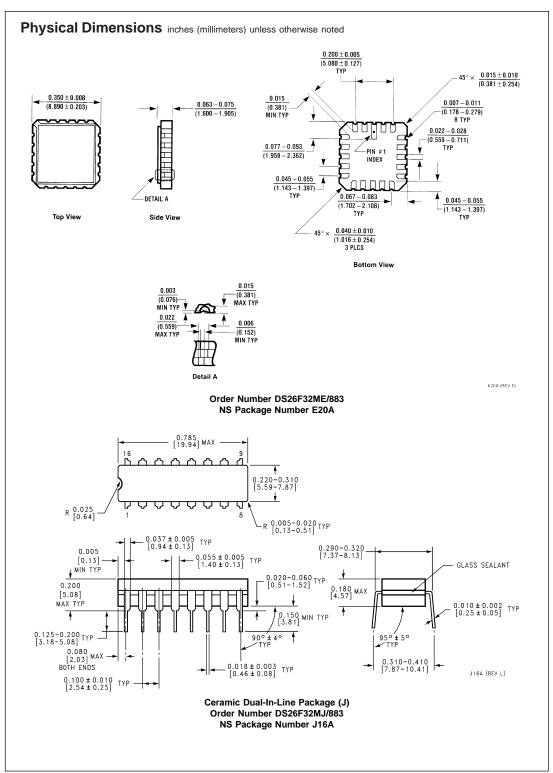
Note 9: All diodes are IN916 or IN3064.

Note 10: C  $_{\rm L}$  includes probe and jig capacitance.

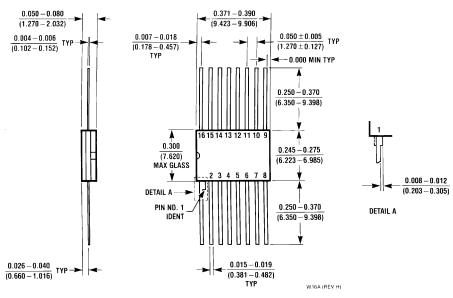
FIGURE 4. Enable and Disable Times (Notes 6, 7, 8)

## **Typical Application**





### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



#### Order Number DS26F32MW/883 NS Package Number W16A

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